

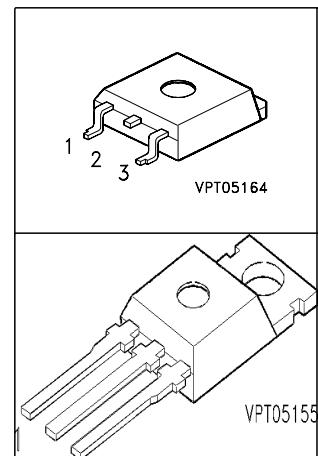
## Smart Lowside Power Switch

### Features

- Logic Level Input
- Input Protection (ESD)
- Thermal shutdown with latch
- Overload protection
- Short circuit protection
- Ovvoltage protection
- Current limitation
- Status feedback with external input resistor
- Analog driving possible

### Product Summary

|                      |                     |      |                  |
|----------------------|---------------------|------|------------------|
| Drain source voltage | $V_{DS}$            | 60   | V                |
| On-state resistance  | $R_{DS(on)}$        | 100  | $\text{m}\Omega$ |
| Current limit        | $I_{D(\text{lim})}$ | 7    | A                |
| Nominal load current | $I_{D(\text{ISO})}$ | 3.5  | A                |
| Clamping energy      | $E_{AS}$            | 1000 | $\text{mJ}$      |

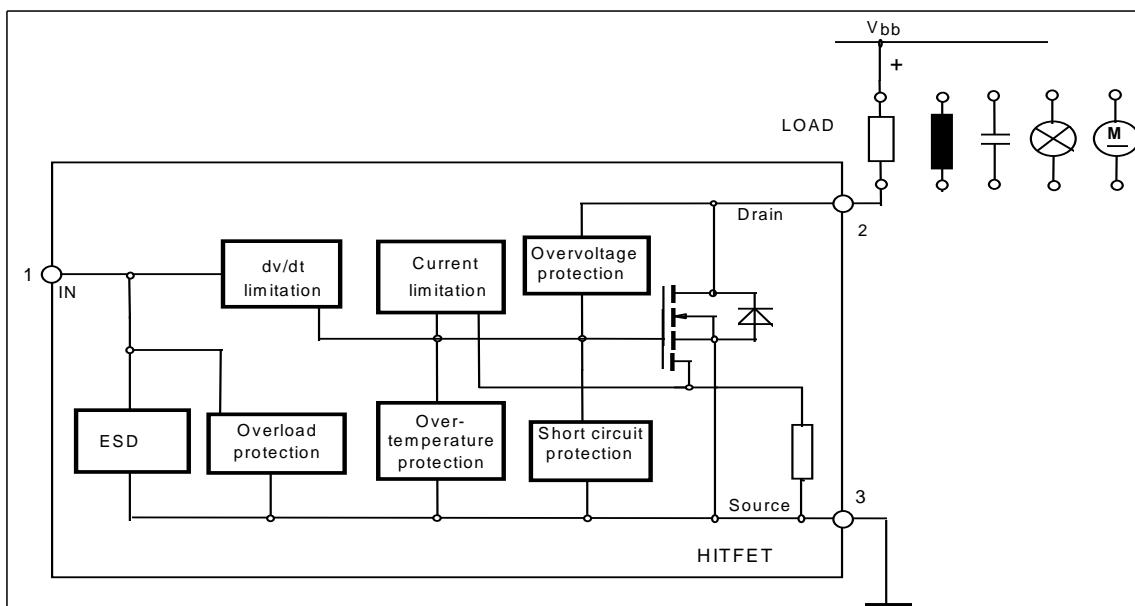


### Application

- All kinds of resistive, inductive and capacitive loads in switching or linear applications
- µC compatible power switch for 12 V and 24 V DC applications
- Replaces electromechanical relays and discrete circuits

### General Description

N channel vertical power FET in Smart SIPMOS® chip on chip technology. Fully protected by embedded protected functions.



**Maximum Ratings at  $T_j = 25^\circ\text{C}$  unless otherwise specified**

| Parameter  | Symbol              | Value                         | Unit             |
|--|---------------------|-------------------------------|------------------|
| Drain source voltage   | $V_{DS}$            | 60                            | V                |
| Drain source voltage for short circuit protection  | $V_{DS(\text{SC})}$ | 32                            |                  |
| Continuous input current <sup>1)</sup><br>$-0.2\text{V} \leq V_{IN} \leq 10\text{V}$<br>$V_{IN} < -0.2\text{V}$ or $V_{IN} > 10\text{V}$   | $I_{IN}$            | no limit<br>$ I_{IN}  \leq 2$ | mA               |
| Operating temperature  | $T_j$               | - 40 ... +150                 | $^\circ\text{C}$ |
| Storage temperature  | $T_{stg}$           | - 55 ... +150                 |                  |
| Power dissipation<br>$T_C = 25^\circ\text{C}$  | $P_{tot}$           | 50                            | W                |
| Unclamped single pulse inductive energy<br>$I_D(\text{ISO}) = 3.5\text{ A}$  | $E_{AS}$            | 1000                          | mJ               |
| Electrostatic discharge voltage (Human Body Model)<br>according to MIL STD 883D, method 3015.7 and<br>EOS/ESD assn. standard S5.1 - 1993   | $V_{ESD}$           | 3000                          | V                |
| Load dump protection $V_{\text{LoadDump}}^2) = V_A + V_S$<br>$V_{IN}=\text{low or high}; V_A=13.5\text{ V}$<br>$t_d = 400\text{ ms}, R_l = 2\Omega, I_D=0.5*3.5\text{A}$<br>$t_d = 400\text{ ms}, R_l = 2\Omega, I_D= 3.5\text{A}$ | $V_{LD}$            | 75<br>70                      |                  |
| DIN humidity category, DIN 40 040  |                     | E                             |                  |
| IEC climatic category; DIN IEC 68-1  |                     | 40/150/56                     |                  |

**Thermal resistance**

|   |            |     |     |
|---|------------|-----|-----|
| junction - case:                          | $R_{thJC}$ | 2.5 | K/W |
| junction - ambient:                       | $R_{thJA}$ | 75  |     |
| SMD version, device on PCB: <sup>3)</sup> | $R_{thJA}$ | 45  |     |

<sup>1)</sup>In case of thermal shutdown a minimum sensor holding current of 500  $\mu\text{A}$  has to be guaranteed (see also page 3).

<sup>2)</sup> $V_{\text{Loaddump}}$  is setup without the DUT connected to the generator per ISO 7637-1 and DIN 40839

<sup>3)</sup>Device on 50mm\*50mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70 $\mu\text{m}$  thick) copper area for Drain connection.  
PCB mounted vertical without blown air.

### Electrical Characteristics

| Parameter<br>at $T_j=25^\circ\text{C}$ , unless otherwise specified  | Symbol              | Values     |           |            | Unit          |
|--|---------------------|------------|-----------|------------|---------------|
|  |                     | min.       | typ.      | max.       |               |
| <b>Characteristics</b>   |                     |            |           |            |               |
| Drain source clamp voltage<br>$T_j = -40 \dots +150^\circ\text{C}, I_D = 10 \text{ mA}$  | $V_{DS(AZ)}$        | 60         | -         | 73         | V             |
| Off state drain current<br>$V_{DS} = 32 \text{ V}, T_j = -40 \dots +150^\circ\text{C}, V_{IN} = 0 \text{ V}$   | $I_{DSS}$           | -          | -         | 5          | $\mu\text{A}$ |
| Input threshold voltage<br>$I_D = 0.7 \text{ mA}$  | $V_{IN(th)}$        | 1.3        | 1.7       | 2.2        | V             |
| Input current - normal operation, $I_D < I_{D(\text{lim})}$ :<br>$V_{IN} = 10 \text{ V}$   | $I_{IN(1)}$         | -          | 30        | 60         | $\mu\text{A}$ |
| Input current - current limitation mode, $I_D = I_{D(\text{lim})}$ :<br>$V_{IN} = 10 \text{ V}$  | $I_{IN(2)}$         | -          | 120       | 300        |               |
| Input current - after thermal shutdown, $I_D = 0 \text{ A}$ :<br>$V_{IN} = 10 \text{ V}$   | $I_{IN(3)}$         | 800        | 2200      | 4000       |               |
| Input holding current after thermal shutdown <sup>1)</sup><br>$T_j = 25^\circ\text{C}$<br>$T_j = 150^\circ\text{C}$  | $I_{IN(H)}$         | 500<br>300 | -<br>-    | -<br>-     |               |
| On-state resistance<br>$V_{IN} = 5 \text{ V}, I_D = 3.5 \text{ A}, T_j = 25^\circ\text{C}$<br>$V_{IN} = 5 \text{ V}, I_D = 3.5 \text{ A}, T_j = 150^\circ\text{C}$   | $R_{DS(on)}$        | -<br>-     | 90<br>180 | 120<br>240 | mΩ            |
| On-state resistance<br>$V_{IN} = 10 \text{ V}, I_D = 3.5 \text{ A}, T_j = 25^\circ\text{C}$<br>$V_{IN} = 10 \text{ V}, I_D = 3.5 \text{ A}, T_j = 150^\circ\text{C}$ | $R_{DS(on)}$        | -<br>-     | 80<br>160 | 100<br>200 |               |
| Nominal load current (ISO 10483)<br>$V_{IN} = 10 \text{ V}, V_{DS} = 0.5 \text{ V}, T_C = 85^\circ\text{C}$  | $I_{D(\text{ISO})}$ | 3.5        | -         | -          | A             |

<sup>1)</sup>If the input current is limited by external components, low drain currents can flow and heat the device.  
Auto restart behaviour can occur.

### Electrical Characteristics

| Parameter  | Symbol | Values |      |      | Unit |
|--|--------|--------|------|------|------|
|  |        | min.   | typ. | max. |      |
| at $T_j=25^\circ\text{C}$ , unless otherwise specified |        |        |      |      |      |

### Characteristics

|   |              |   |    |    |   |
|---|--------------|---|----|----|---|
| Initial peak short circuit current limit<br>$V_{IN} = 10 \text{ V}, V_{DS} = 12 \text{ V}$                                | $I_{D(SCp)}$ | - | 25 | -  | A |
| Current limit 1)<br>$V_{IN} = 10 \text{ V}, V_{DS} = 12 \text{ V}, t_m = 350 \mu\text{s}, T_j = -40...+150^\circ\text{C}$ | $I_{D(lim)}$ | 7 | 10 | 15 |   |

### Dynamic Characteristics

|   |                    |   |    |     |                        |
|---|--------------------|---|----|-----|------------------------|
| Turn-on time $V_{IN}$ to 90% $I_D$ :<br>$R_L = 4.7 \Omega, V_{IN} = 0$ to 10 V, $V_{bb} = 12 \text{ V}$   | $t_{on}$           | - | 40 | 70  | $\mu\text{s}$          |
| Turn-off time $V_{IN}$ to 10% $I_D$ :<br>$R_L = 4.7 \Omega, V_{IN} = 10$ to 0 V, $V_{bb} = 12 \text{ V}$  | $t_{off}$          | - | 70 | 150 |                        |
| Slew rate on     70 to 50% $V_{bb}$ :<br>$R_L = 4.7 \Omega, V_{IN} = 0$ to 10 V, $V_{bb} = 12 \text{ V}$  | $-dV_{DS}/dt_{on}$ | - | 1  | 3   | $\text{V}/\mu\text{s}$ |
| Slew rate off     50 to 70% $V_{bb}$ :<br>$R_L = 4.7 \Omega, V_{IN} = 10$ to 0 V, $V_{bb} = 12 \text{ V}$ | $dV_{DS}/dt_{off}$ | - | 1  | 3   |                        |

### Protection Functions

|   |          |      |     |    |                  |
|---|----------|------|-----|----|------------------|
| Thermal overload trip temperature   | $T_{jt}$ | 150  | 165 | -  | $^\circ\text{C}$ |
| Unclamped single pulse inductive energy<br>$I_D = 3.5 \text{ A}, T_j = 25^\circ\text{C}, V_{bb} = 32 \text{ V}$ | $E_{AS}$ |      |     |    | $\text{mJ}$      |
| $I_D = 3.5 \text{ A}, T_j = 150^\circ\text{C}, V_{bb} = 32 \text{ V}$   |          | 1000 | --  | -- |                  |
|   |          | 225  | --  | -- |                  |

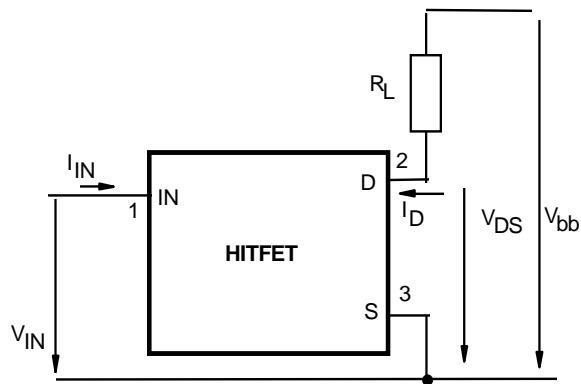
### Inverse Diode

|   |          |   |   |   |   |
|---|----------|---|---|---|---|
| Inverse diode forward voltage<br>$I_F = 5 * 3.5 \text{ A}, t_m = 300 \mu\text{s}, V_{IN} = 0 \text{ V}$ | $V_{SD}$ | - | 1 | - | V |
|---|----------|---|---|---|---|

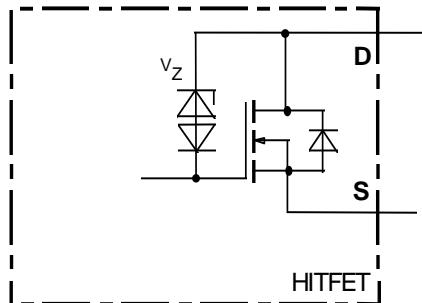
<sup>1</sup>Device switched on into existing short circuit (see diagram Determination of  $I_{D(lim)}$ ). If the device is in on condition and a short circuit occurs, these values might be exceeded for max. 50  $\mu\text{s}$ .

## Block Diagramm

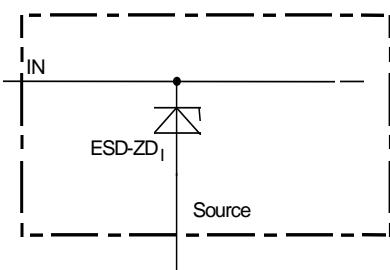
### Terms



### Inductive and overvoltage output clamp

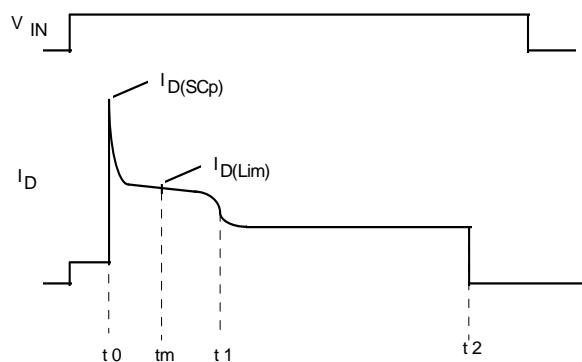


### Input circuit (ESD protection)



ESD zener diodes are not designed for DC current > 2 mA @  $V_{IN} > 10V$ .

### Short circuit behaviour



$t_0$ : Turn on into a short circuit

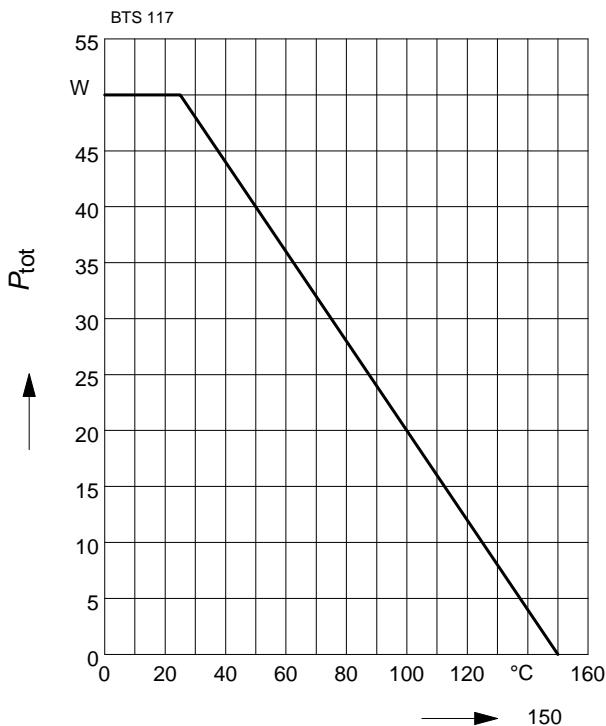
$t_m$ : Measurement point for  $I_D(\text{lim})$

$t_1$ : Activation of the fast temperature sensor and regulation of the drain current to a level where the junction temperature remains constant.

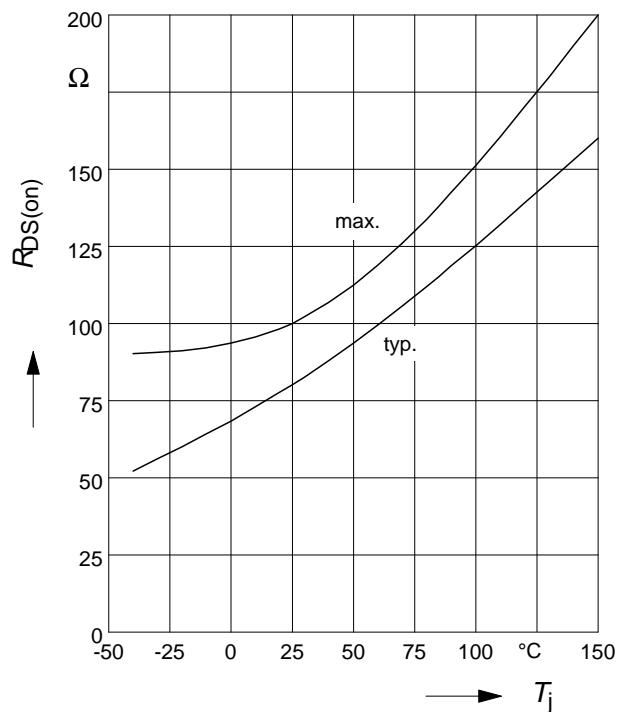
$t_2$ : Thermal shutdown caused by the second temperature sensor, achieved by an integrating measurement.

**Maximum allowable power dissipation**

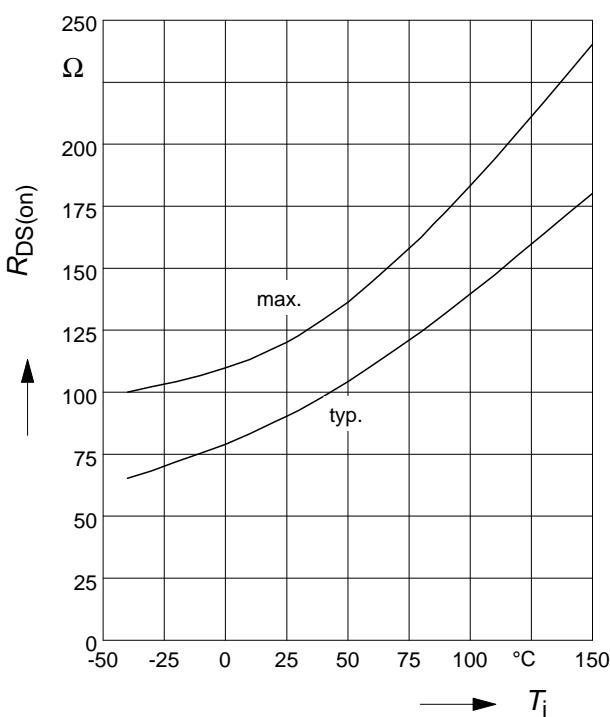
$$P_{\text{tot}} = f(T_c)$$


**On-state resistance**

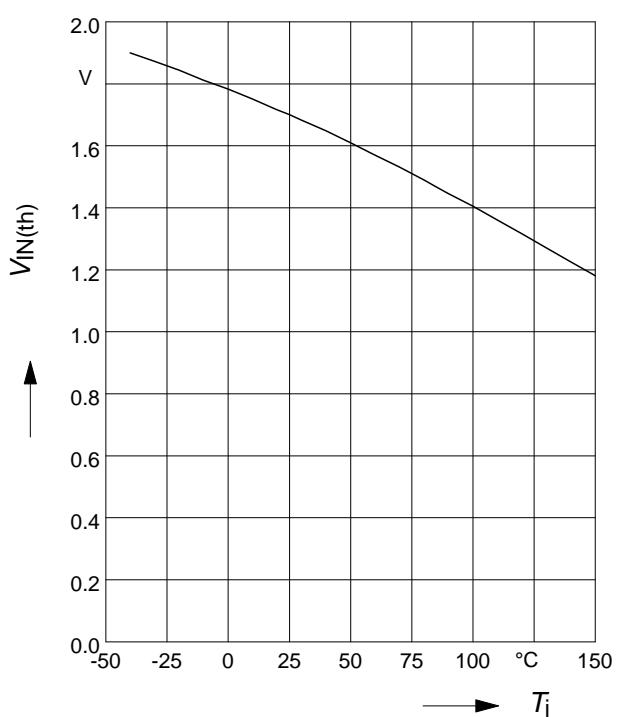
$$R_{\text{ON}} = f(T_j); I_D = 3.5 \text{ A}; V_{\text{IN}} = 10 \text{ V}$$

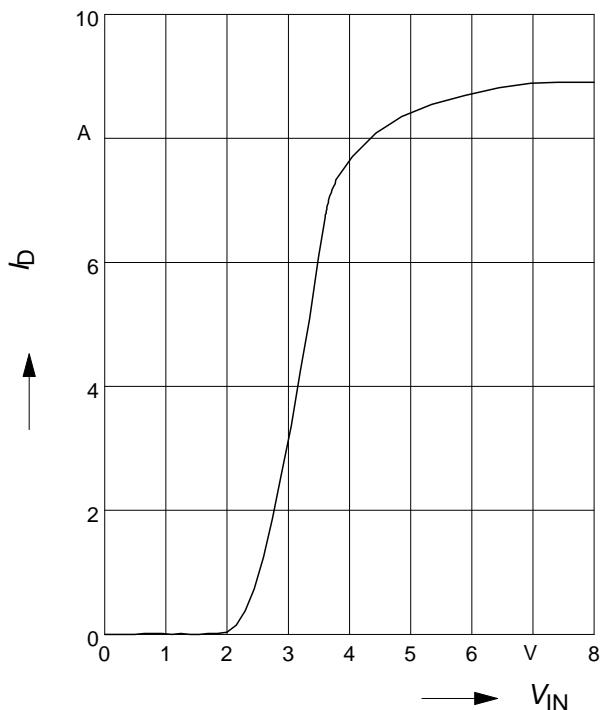

**On-state resistance**

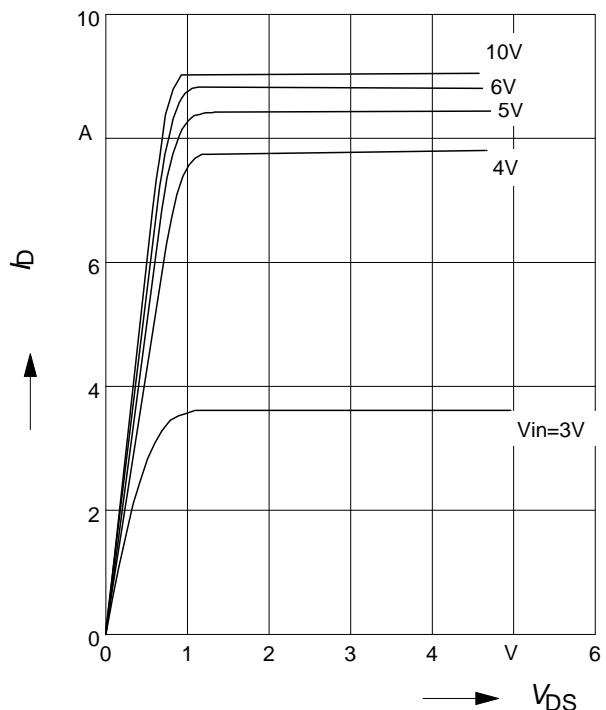
$$R_{\text{ON}} = f(T_j); I_D = 3.5 \text{ A}; V_{\text{IN}} = 5 \text{ V}$$


**Typ. input threshold voltage**

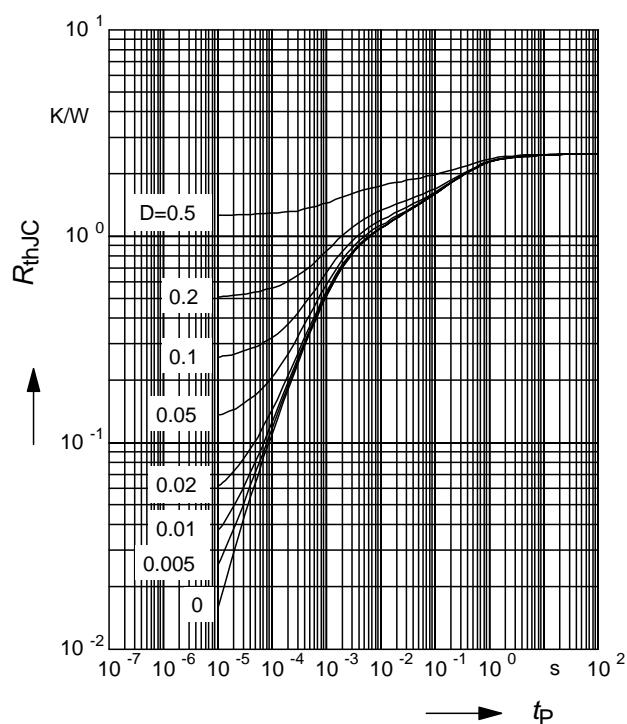
$$V_{\text{IN(th)}} = f(T_j); I_D = 0.7 \text{ mA}; V_{\text{DS}} = 12 \text{ V}$$



**Typ. transfer characteristics**
 $I_D = f(V_{IN})$ ;  $V_{DS}=12V$ ;  $T_j=25^\circ C$ 

**Typ. output characteristic**
 $I_D = f(V_{DS})$ ;  $T_j=25^\circ C$ 

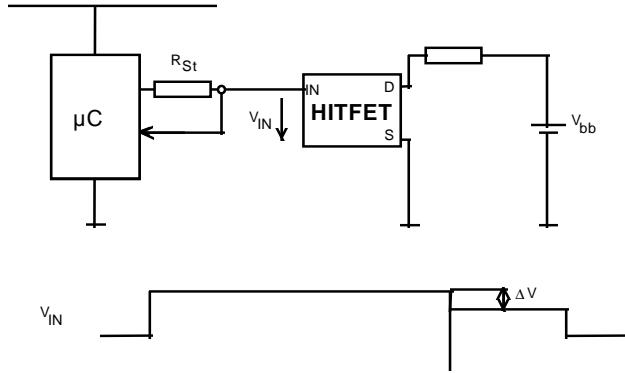
Parameter:  $V_{IN}$ 

**Transient thermal impedance**

$Z_{thJC} = f(t_p)$

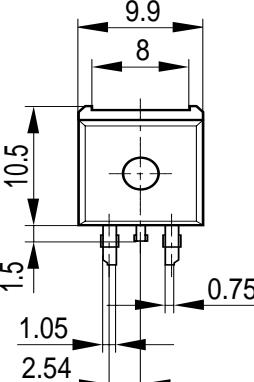
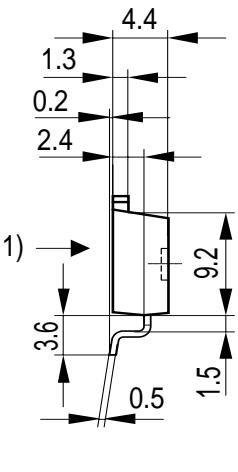
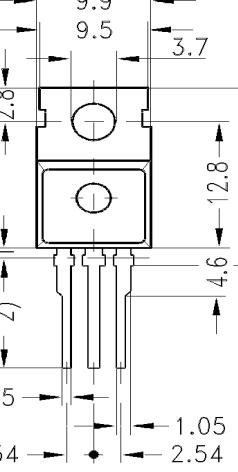
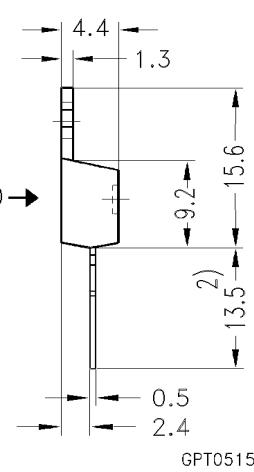
parameter :  $D = t_p/T$ 


### Application examples:

#### Status signal of thermal shutdown by monitoring input current



$$\Delta V = R_{ST} * I_{IN(3)}$$

| Package   | Ordering Code   | Package  | Ordering Code   |
|---|---|--|---|
| P-TO220-3-45  | Q67060-S6500-A3   | P-TO220-3-1  | Q67060-S6500-A2   |
| <br>1) shear and punch direction no burrs this surface | <br>GPT05164 | <br>1) → | <br>GPT05155 |

1) punch direction, burr max. 0.04  
 2) dip tinning  
 3) max. 14.5 by dip tinning press burr max. 0.05

**Published by**

**Infineon Technologies AG,  
Bereichs Kommunikation**

**St.-Martin-Strasse 53,  
D-81541 München**

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